


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566869	<b>Applicant(s)/Patent Under Reexamination</b>  NAGAI ET AL.
	<b>Examiner</b>  THOMAS DIAZ	<b>Art Unit</b>  4171

SEARCHED			
Class	Subclass	Date	Examiner
74	490.01-490.05	2/28/2008	/TD/
901	15,27-29	2/28/2008	/TD/

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS search done.	2/28/2008	/TD/
Search of US and Foreign Patents in EAST; search history attached.	2/28/2008	/TD/
Inventor Search in Palm/eDAN.	2/28/2008	/TD/
Consulted with Larry Tarazano.	2/28/2008	/TD/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner